# USB-6346 Specifications

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# Contents

# USB-6346 Specifications

#### **Definitions**

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty.

**Characteristics** describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- Typical specifications describe the performance met by a majority of models.
- **Nominal** specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

Specifications are **Typical** unless otherwise noted.

#### **Conditions**

Specifications are valid for 25 °C unless otherwise noted.

### **Analog Input**

Note Floating inputs can cause unnecessary power consumption and higher operating temperatures. NI recommends connecting unused analog input channels to AI GND.

Number of channels	8 differential
ADC resolution	16 bits

DNL	No missing codes, warranted		
INL	Refer to the <b>AI Absolute Accuracy</b> section.		
Sample rate (simultaneous	sampling on all channels sampled)		
Maximum	500 kS/s		
Minimum	No minimum		
Timing resolution	10 ns		
Timing accuracy	50 ppm of sample rate		
Input coupling	DC		
Input range	±1 V, ±2 V, ±5 V, ±10 V		
Maximum working voltage f	for all analog inputs (AI±)		
Ranges ±10 V, ±5 V	±11 V, Measurement Category I		
Ranges ±2 V, ±1 V	±9 V, Measurement Category I		

**Caution** Do not connect the USB-6346 to signals or use for measurements within Measurement Categories II, III, or IV.

**Attention** Ne connectez pas le USB-6346 à des signaux et ne l'utilisez pas pour effectuer des mesures dans les catégories de mesure II, III ou IV.

CMRR (at 60 Hz)	80 dB

Bandwidth (small signal)	2.0 MHz at ±1 V
	2.9 MHz at other ranges
Input impedance	
Device on	
AI+ to AI GND	>1 G $\Omega$ in parallel with 18 pF
AI- to AI GND	>1 G $\Omega$ in parallel with 18 pF
Device off	
AI+ to AI GND	2.37 kΩ
AI- to AI GND	2.37 kΩ
Input bias current	±6 nA
	±90 nA, maximum over full temperature range
Crosstalk (at 100 kHz)	-80 dB
Input FIFO size	32 MS shared among channels used
Data transfers	USB Signal Stream, programmed I/O
Overvoltage protection for AI <	<07>
Device on	±30 V
Device off	±15 V
Input current during overvoltage	e conditions ±6.3 mA maximum/Al pin

Maximum AI channels in overvoltage	4

**Notice** Exceeding overvoltage specifications may result in data corruption on non-overvoltaged channels.

# **Analog Triggers**

Number of triggers	1
Source	AI <07>, APFI 0
Functions	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Source level	
AI <07>	±Full scale
APFI 0	±10 V
Resolution	16 bits
Modes	Analog edge triggering, analog edge triggering with hysteresis, and analog window triggering
Bandwidth (large	signal, to -3 dB)
AI <07>	600 kHz
APFI 0	3.9 MHz
Accuracy	±1% of range

APFI 0 characteristics Input impedance	10 kΩ
Coupling	DC
Protection, power on	±30 V
Protection, power off	±15 V

### Al Absolute Accuracy

Nominal Range Positive Full Scale	Nominal Range Negative Full Scale	Residual Gain Error (ppm of Reading)	Offset Tempco (ppm of Range/°C)	Random Noise, σ (μVrms)	Absolute Accuracy at Full Scale (µV)
10	-10	115	2	265	3,225
5	-5	115	2	148	1,613
2	-2	117	2	74	650
1	-1	124	3	50	333

Table 1. Al Absolute Accuracy

Note For more information about absolute accuracy at full scale, refer to the AI Absolute Accuracy Example section.

Gain tempco	16.7 ppm/°C
Reference tempco	5 ppm/°C
Residual offset error	12 ppm of range
INL error	126 ppm of range

**Note** Accuracies listed are warranted for up to one year from the device external calibration when the device is within 10 °C of the external calibration temperature and 1 °C of the last self calibration, when averaging 10,000 DC samples. Other accuracies may be calculated for different temperatures and sample sizes using the given equations.

**Notice** This product may become more sensitive to electromagnetic disturbances in the operational environment when test leads are attached or when connected to a test object.

#### Al Absolute Accuracy Equation

AbsoluteAccuracy = Reading  $\cdot$  (GainError) + Range  $\cdot$  (OffsetError) + NoiseUncertainty

- GainError = ResidualGainError + GainTempco
- · (TempChangeFromLastInternalCal) + ReferenceTempco · (TempChangeFromLastExternalCal)
- OffsetError = ResidualOffsetError + OffsetTempco · (TempChangeFromLastInternalCal) + INLError
- NoiseUncertainty =

```
\frac{\text{Random Noise}}{\sqrt{10.000}}
```

for a coverage factor of 3  $\sigma$  and averaging 10,000 points.

#### AI Absolute Accuracy Example

Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

- TempChangeFromLastExternalCal = 10 °C
- TempChangeFromLastInternalCal = 1 °C
- number\_of\_readings = 10,000
- CoverageFactor = 3 σ

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

- **GainError** = 115 ppm + 16.7 ppm  $\cdot$  1 + 5 ppm  $\cdot$  10 = 181.7 ppm
- OffsetError = 12 ppm + 2 ppm ·1 + 126 ppm = 140 ppm
- Noise Uncertainty =

```
265\,\mu V \quad 3
  \sqrt{10,000}
= 8 \mu V
```

■ AbsoluteAccuracy = 10 V · (GainError) + 10 V · (OffsetError) + **NoiseUncertainty** =  $3225 \mu V$ 

### **Analog Output**

Number of channels	2
DAC resolution	16 bits
DNL	±1 LSB, maximum
Monotonicity	16 bit guaranteed
Accuracy	Refer to the <b>AO Absolute Accuracy</b> section.
Maximum update rate (simultaneous)	
Maximum update rate (simultaneous)  1 channel	900 kS/s
	900 kS/s 840 kS/s
1 channel	

Timing resolution 10 ns  Output range ±10 V  Output coupling DC  Output impedance 0.2 Ω  Output current drive ±5 mA  Overdrive protection ±15 V  Overdrive current 15 mA  Power-on state ±20 mV  Power-on/off glitch[1] 2 V peak for 1.5 s  Output FIFO size 8,191 samples shared among channels used  Data transfers USB Signal Stream, programmed I/O  AO waveform modes Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update  Settling time, full-scale step, 15 ppm (1 LSB)  Slew rate 15 V/μs  Glitch energy at midscale transition 100 mV · 2.6 μs		
Output coupling       DC         Output impedance       0.2 Ω         Output current drive       ±5 mA         Overdrive protection       ±15 V         Overdrive current       15 mA         Power-on state       ±20 mV         Power-on/off glitch [1]       2 V peak for 1.5 s         Output FIFO size       8,191 samples shared among channels used         Data transfers       USB Signal Stream, programmed I/O         AO waveform modes       Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update         Settling time, full-scale step, 15 ppm (1 LSB)       6 μs         Slew rate       15 V/μs	Timing resolution	10 ns
Output impedance       0.2 Ω         Output current drive       ±5 mA         Overdrive protection       ±15 V         Overdrive current       15 mA         Power-on state       ±20 mV         Power-on/off glitch[1]       2 V peak for 1.5 s         Output FIFO size       8,191 samples shared among channels used         Data transfers       USB Signal Stream, programmed I/O         AO waveform modes       Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update         Settling time, full-scale step, 15 ppm (1 LSB)       6 μs         Slew rate       15 V/μs	Output range	±10 V
Output current drive ±5 mA  Overdrive protection ±15 V  Overdrive current 15 mA  Power-on state ±20 mV  Power-on/off glitch[1] 2 V peak for 1.5 s  Output FIFO size 8,191 samples shared among channels used  Data transfers USB Signal Stream, programmed I/O  AO waveform modes Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update  Settling time, full-scale step, 15 ppm (1 LSB) 6 µs  Slew rate 15 V/µs	Output coupling	DC
Overdrive protection       ±15 V         Overdrive current       15 mA         Power-on state       ±20 mV         Power-on/off glitch[1]       2 V peak for 1.5 s         Output FIFO size       8,191 samples shared among channels used         Data transfers       USB Signal Stream, programmed I/O         AO waveform modes       Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update         Settling time, full-scale step, 15 ppm (1 LSB)       6 μs         Slew rate       15 V/μs	Output impedance	0.2 Ω
Overdrive current       15 mA         Power-on state       ±20 mV         Power-on/off glitch[1]       2 V peak for 1.5 s         Output FIFO size       8,191 samples shared among channels used         Data transfers       USB Signal Stream, programmed I/O         AO waveform modes       Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update         Settling time, full-scale step, 15 ppm (1 LSB)       6 μs         Slew rate       15 V/μs	Output current drive	±5 mA
Power-on state ±20 mV  Power-on/off glitch[1] 2 V peak for 1.5 s  Output FIFO size 8,191 samples shared among channels used  Data transfers USB Signal Stream, programmed I/O  AO waveform modes Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update  Settling time, full-scale step, 15 ppm (1 LSB) 6 μs  Slew rate 15 V/μs	Overdrive protection	±15 V
Power-on/off glitch       2 V peak for 1.5 s         Output FIFO size       8,191 samples shared among channels used         Data transfers       USB Signal Stream, programmed I/O         AO waveform modes       Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update         Settling time, full-scale step, 15 ppm (1 LSB)       6 μs         Slew rate       15 V/μs	Overdrive current	15 mA
Output FIFO size  8,191 samples shared among channels used  USB Signal Stream, programmed I/O  Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update  Settling time, full-scale step, 15 ppm (1 LSB) 6 μs  Slew rate  15 V/μs	Power-on state	±20 mV
Data transfers  USB Signal Stream, programmed I/O  Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update  Settling time, full-scale step, 15 ppm (1 LSB) 6 μs  Slew rate  15 V/μs	Power-on/off glitch[1]	2 V peak for 1.5 s
AO waveform modes $\begin{array}{c} \text{Non-periodic waveform, periodic waveform} \\ \text{regeneration mode from onboard FIFO, periodic} \\ \text{waveform regeneration from host buffer including} \\ \text{dynamic update} \\ \text{Settling time, full-scale step, 15 ppm (1 LSB)} \\ \text{6 } \mu s \\ \text{Slew rate} \\ \\ \text{15 V/} \mu s \\ \end{array}$	Output FIFO size	8,191 samples shared among channels used
regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update  Settling time, full-scale step, 15 ppm (1 LSB) 6 μs  Slew rate  15 V/μs	Data transfers	USB Signal Stream, programmed I/O
Slew rate 15 V/μs	AO waveform modes	regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including
	Settling time, full-scale step, 15 ppm (1 LSB)	6 μs
Glitch energy at midscale transition 100 mV · 2.6 μs	Slew rate	15 V/μs
	Glitch energy at midscale transition	100 mV · 2.6 μs

#### **AO Absolute Accuracy**

Accuracies listed are warranted for up to one year from the device external calibration when the device is within 10 °C of the external calibration temperature and 1 °C of the last self calibration.

Nominal	Nominal	Residual	Gain	Reference	Residual	Offset	INL	Absolute
Range	Range	Gain Error	Tempco	Tempco	Offset	Tempco	Error	Accuracy
Positive	Negative	(ppm of	(ppm/°C)	(ppm/°C)	Error	(ppm of	(ppm of	at Full
Full Scale	Full Scale	Reading)			(ppm of	Range/	Range)	Scale (µV)
					Range)	°C)		
10	-10	130	11.3	5	52	4.8	128	3,761

Table 2. AO Absolute Accuracy

#### **AO Absolute Accuracy Equation**

AbsoluteAccuracy = OutputValue (GainError) + Range (OffsetError)

- GainError = ResidualGainError + GainTempco · (TempChangeFromLastInternalCal) + ReferenceTempco (TempChangeFromLastExternalCal)
- OffsetError = ResidualOffsetError + OffsetTempco · (TempChangeFromLastInternalCal) + INLError

### Digital I/O/PFI

#### Static Characteristics

Number of channels	24 total
	8 (P0.<07>)
	16 (PFI <07>/P1, PFI <815>/P2)
Ground reference	D GND

Direction control	Each terminal individually programmable as input or output
Pull-down resistor	50 k $\Omega$ , typical 20 k $\Omega$ , minimum
Input voltage protection	±20 V on up to two pins

**Notice** Stresses beyond those listed under the **Input voltage protection** specification may cause permanent damage to the device.

### Waveform Characteristics (Port 0 Only)

Terminals used	Port 0 (P0.<07>)
Port/sample size	Up to 8 bits
Waveform generation (DO) FIFO	2,047 samples
Waveform acquisition (DI) FIFO	255 samples
DI Sample Clock frequency	0 to 1 MHz, system and bus activity dependent
DO Sample Clock frequency	
	L MHz
Regenerate from FIFO 0 to 2	L MHz L MHz, system and bus activity dependent
Regenerate from FIFO 0 to 2	

### PFI/Port 1/Port 2 Functionality

Functionality	Static digital input, static digital output, timing input, timing output
Timing output sources	Many AI, AO, counter, DI, DO timing signals
Debounce filter settings	90 ns, 5.12 μs, 2.56 ms, custom interval, disable; programmable high and low transitions; selectable per input

# **Recommended Operating Conditions**

Input high voltage (V <sub>IH</sub> )		
Minimum	2.2 V	
Maximum	5.25 V	
Input low voltage (V <sub>IL</sub> )		
Minimum	0 V	
Maximum	0.8 V	
Output high current (I <sub>OH</sub> )		
P0.<07>	-24 mA, maximum	
PFI <015>/P1/P2	-16 mA, maximum	
Output low current (I <sub>OL</sub> )		
P0.<07>	24 mA, maximum	

PFI <0.	.15>/	P1/	/P2
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#### 16 mA, maximum

# Digital I/O Characteristics

Positive-going threshold (VT+)	2.2 V, maximum
Negative-going threshold (VT-)	0.8 V, minimum
Delta VT hysteresis (VT+ - VT-)	0.2 V, minimum
I <sub>IL</sub> input low current (V <sub>IN</sub> = 0 V)	-10 μA, maximum
I <sub>IH</sub> input high current (V <sub>IN</sub> = 5 V)	250 μA, maximum

Figure 1. P0.<0..7>: I<sub>OH</sub> versus V<sub>OH</sub>

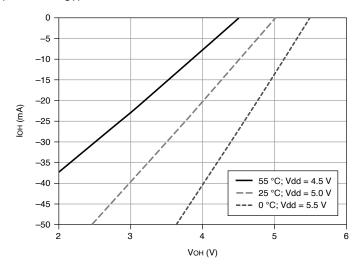


Figure 2. P0.<0..7>: I<sub>OL</sub> versus V<sub>OL</sub>

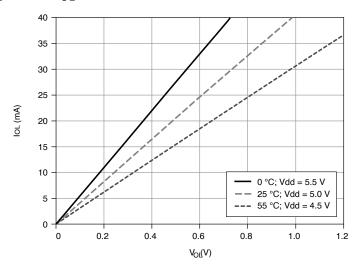
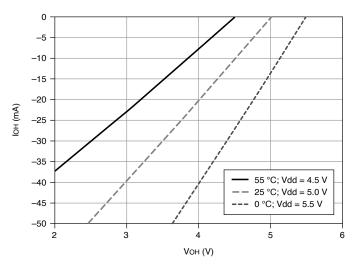


Figure 3. PFI <0..15>/P1/P2: I<sub>OH</sub> versus V<sub>OH</sub>



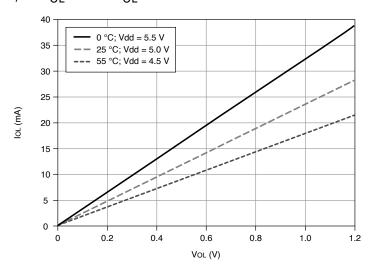


Figure 4. PFI <0..15>/P1/P2:  $I_{OL}$  versus  $V_{OL}$ 

# General-Purpose Counters

Number of counter/timers	4
Resolution	32 bits
Counter measurements	Edge counting, pulse, pulse width, semi-period, period, two-edge separation
Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two- pulse encoding
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling
Internal base clocks	100 MHz, 20 MHz, 100 kHz
External base clock frequency	0 MHz to 25 MHz
Base clock accuracy	50 ppm

Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down, Sample Clock
Routing options for inputs	Any PFI, many internal signals
FIFO	127 samples per counter
Data transfers	USB Signal Stream, programmed I/O

# Frequency Generator

Number of channels	1
Base clocks	20 MHz, 10 MHz, 100 kHz
Divisors	1 to 16
Base clock accuracy	50 ppm

Output can be available on any PFI terminal.

# Phase-Locked Loop (PLL)

Number of PLLs	1

Reference Signal	USB Locking Input Frequency
PFI <015>	10 MHz

Table 3. Reference Clock Locking Frequencies

Output of PLL	100 MHz Timebase; other signals derived from 100 MHz Timebase including
	20 MHz and 100 kHz Timebases

### External Digital Triggers

Source	Any PFI
Polarity	Software-selectable for most signals
Analog input function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase
Analog output function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Counter/timer functions	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down, Sample Clock
Digital waveform generation (DO) function	Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase
Digital waveform acquisition (DI) function	Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase

### **Bus Interface**

USB compatibility[2]	USB 2.0 Hi-Speed or full-speed
USB Signal Stream	8 (can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1, counter/timer 2, counter/timer 3)

## **Power Requirements**

**Caution** The protection provided by the USB-6346 can be impaired if it is used in a manner not described in the user documentation.

**Attention** La protection apportée par le USB-6346 risque d'être endommagée s'il est utilisé d'une autre façon que celle décrite dans la documentation utilisateur.

Power supply requirements	11 V DC to 30 V DC, 30 W, 2 positions 3.5 mm pitch pluggable screw terminal with screw locks similar to Phoenix Contact MC 1,5/2-STF-3,5 BK
Power input mating connector	Phoenix Contact MC 1,5/2-GF-3,5 BK or equivalent

Caution The USB-6346 must be powered with an AC adapter offered by NI or a National Electric Code (NEC) Class 2 DC source that meets the power requirements for the device and has appropriate safety certification marks for country of use.

**Attention** Le USB-6346 doit être alimenté par un adaptateur secteur proposé par NI ou une source de courant continu de classe 2, selon la norme NEC (National Electric Code), qui répond aux exigences d'alimentation de l'appareil et possède les marques de certification de sécurité appropriées pour le pays d'utilisation.

#### **Current Limits**

Notice Exceeding the current limits may cause unpredictable device behavior.

+5 V terminal (connector 0)	1 A, maximum

**Note** Connector 0 has a self-resetting fuse that opens when current exceeds this specification.

P0/PFI/P1/P2 and +5 V terminals combined	1.2 A, maximum

# **Physical Characteristics**

Screw terminal Enclosure dimensions (includes	26.4 cm × 17.3 cm × 3.6 cm (10.39 in. × 6.81 in. × 1.42 in.)
connectors) Weight	1.45 kg (3 lb 3 oz)
I/O connectors	64 screw terminals
BNC	
Enclosure dimensions (includes connectors)	20.3 cm × 18.5 cm × 6.8 cm (7.99 in. × 7.28 in. × 2.68 in.)
Weight	1.80 kg (4 lb 0 oz)
I/O connectors	20 BNC terminals
	30 screw terminals
Screw terminal wire gauge	0.2 mm <sup>2</sup> to 1.3 mm <sup>2</sup> (24 AWG to 16 AWG)

### Calibration

Recommended warm-up time	15 minutes
Calibration interval	1 year

### Maximum Working Voltage

Maximum working voltage refers to the signal voltage plus the common-mode voltage.

Channel to earth	11 V, Measurement Category I

Caution Do not connect the USB-6346 to signals or use for measurements within Measurement Categories II, III, or IV.

Attention Ne connectez pas le USB-6346 à des signaux et ne l'utilisez pas pour effectuer des mesures dans les catégories de mesure II, III ou IV.

Measurement Category I is for measurements performed on circuits not directly connected to the electrical distribution system referred to as MAINS voltage. MAINS is a hazardous live electrical supply system that powers equipment. This category is for measurements of voltages from specially protected secondary circuits. Such voltage measurements include signal levels, special equipment, limited-energy parts of equipment, circuits powered by regulated low-voltage sources, and electronics.

**Note** Measurement Categories CAT I and CAT O are equivalent. These test and measurement circuits are for other circuits not intended for direct connection to the MAINS building installations of Measurement Categories CAT II, CAT III, or CAT IV.

#### **Environmental Guidelines**

**Notice** This model is intended for use in indoor applications only.

#### **Environmental Characteristics**

Temperature	
Operating	0 °C to 45 °C
Storage	-40 °C to 70 °C
Humidity	
Operating 1	.0% to 90% RH, noncondensing
Storage 5	5% to 95% RH, noncondensing
Pollution Degree	2
Maximum altitude	2,000 m (800 mbar) (at 25 °C ambient temperature)

 $<sup>^1</sup>_-$  Typical behavior. Time period may be longer due to host system USB performance. Time period will be longer during firmware updates.

 $<sup>^2</sup>$  Operating on a full-speed bus results in lower performance, and you might not be able to achieve maximum sampling/update rates.